Electronic Supplementary Material (ESI) for Soft Matter.
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## **ELECTRONIC SUPPLEMENTARY INFORMATION**

## Unravelling structural rearrangement of polymer colloidal crystals under dry sintering conditions

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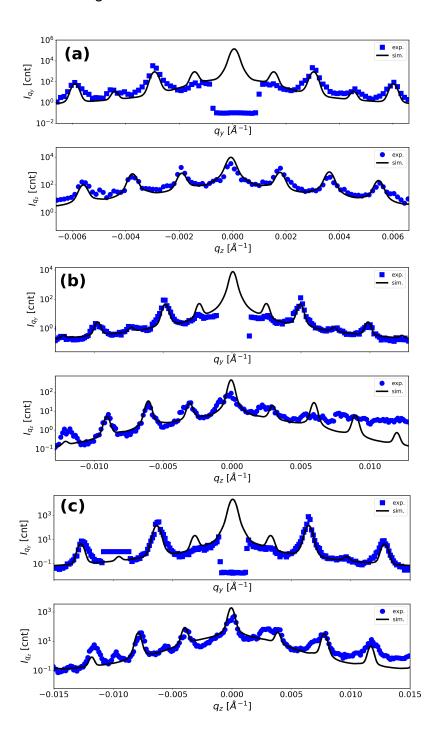
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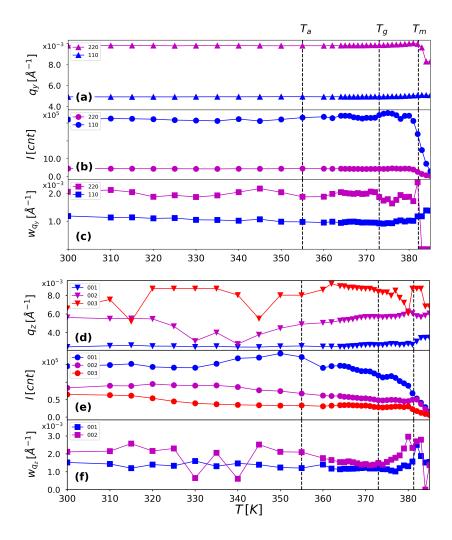
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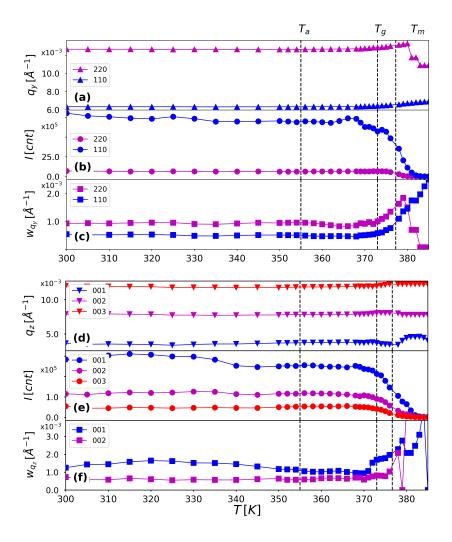
**Figure S1** GTSAXS intensity profiles (dots) and fitting curves (lines) for the PS colloidal crystal samples (a) A, (b) B and (c) C at RT. For each sample the top and the bottom profiles refer to  $q_y$ -and  $q_z$ -directions (depicted as dashed lines in Figure 3 of the main text), respectively.  $q_y$ -profiles include diffraction peaks up to (220) order and  $q_z$ -profiles include peaks up to (003) order. Structural parameters deduced from fitting curves are summarized in Table 1 of the main text.



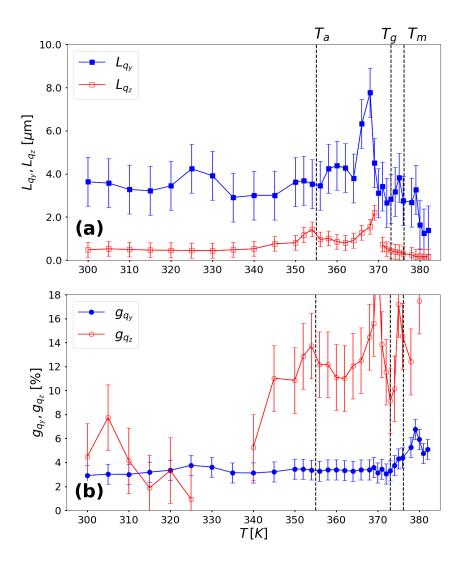
**Figure S2** Temperature dependences of GTSAXS peak positions, integrated intensities and widths of the PS colloidal crystal sample B for (a-c) in-plane and (d-f) out-of-plane directions.



**Figure S3** Temperature dependences of GTSAXS peak positions, integrated intensities and widths of the PS colloidal crystal sample C for (a-c) in-plane and (d-f) out-of-plane directions.



**Figure S4** Temperature dependences of (a) CSD sizes and (b) lattice deformation parameters for in-plane (blue filled dots) and out-of-plane (red open dots) directions of the sample C.



**Figure S5** Experimental (dots) and simulated (lines) GTSAXS intensity profiles for the PS colloidal crystal sample A at T=376 K. Calculated curves were obtained using the scattering functions of a single shape (dashed line) and 1:1 mixture of spheres and rhombic dodecahedrons (solid line).

